

Notice of References Cited	Application/Control No. 10/040,402	Applicant(s)/Patent Under Reexamination SHIRAIWA, YOSHINOBU	
	Examiner, Huan H. Tran	Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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NON-PATENT DOCUMENTS

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